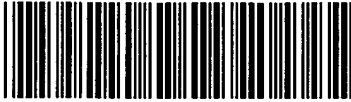


**Search Notes**

Application/Control No.

10/500,131

Examiner

James K. Trujillo

Applicant(s)/Patent under  
Reexamination

MADTER ET AL.

Art Unit

2116

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB), see attached; NPL: IEEE; Inventor Search/DP	9/20/2006	JKT
Updated; text with class 713/1-340	3/15/2007	JKT